




Search Notes 	Application/Control No. 10668837	Applicant(s)/Patent Under Reexamination HYSOM ET AL.
	Examiner Jacob, Mary C	Art Unit 2123

Notes	Date	Examiner
Inventor Name Search: EAST, eDAN, IEEE, ACM	09/26/2006	MCJ
Assignee Name Search: EAST, Google Scholar: "ncr" "data warehousing" modeling quality maturity map; www.ncr.com; www.teradata.com	09/26/2006	MCJ
East Search: See Search History	09/26/2006	MCJ
Google Scholar: "data warehousing" visualization "information quality" "3D" link surface OR face; "information quality" visualization	09/27/2006	MCJ
ACM: "data quality" legacy, model; "information quality", legacy, model	09/27/2006	MCJ
U.S. Patent and Trademark Office		Part of Paper No.:

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Class	SubClass	Date	Examiner
703	1,2	09/27/2006	MCJ

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